

<b>Notice of References Cited</b>	Application/Control No. 10/026,010	Applicant(s)/Patent Under Reexamination HAYDUK, MATTHEW A.	
	Examiner Sharad Rampuria	Art Unit 2683	Page 1 of 1

**U.S. PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	A	US-6,591,116 B1	07-2003	Laurila et al.	455/558
	B	US-2002/0119776 A1	08-2002	Vestergaard et al.	455/436
	C	US-6,002,936 A	12-1999	Roel-Ng et al.	455/456.4
	D	US-6,141,547 A	10-2000	Rousseau et al.	455/426.1
	E	US-5,878,344 A	03-1999	Zicker, Robert G.	455/426.1
	F	US-2003/0013434 A1	01-2003	Rosenberg et al.	455/414
	G	US-6,397,065 B1	05-2002	Huusko et al.	455/435.2
	H	US-6,516,197 B2	02-2003	Havinis et al.	455/456.1
	I	US-6,594,488 B1	07-2003	Chow et al.	455/426.1
	J	US-6,654,362 B1	11-2003	Palamara, Maria E.	370/332
	K	US-2003/0008644 A1	01-2003	Akhterzzaman et al.	455/418
	L	US-6,771,964 B1	08-2004	Einola et al.	455/437
	M	US-6,546,246 B1	04-2003	Bridges et al.	455/432.1

**FOREIGN PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	O					
	P					
	Q					
	R					
	S					
	T					

**NON-PATENT DOCUMENTS**

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
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	V	
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	X	

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